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High-Speed Synchronous Buck Controller

Features:

- Input Voltage Range: from 4.5V to 30V
- Targeted for Low-Voltage Power Trains with Output Current up to 20A
- High-Speed Voltage Mode, Analog Pulse-Width Modulation Control
- Power Good Output
- Internal Oscillator, Reference Voltage and Overcurrent Limit Threshold for Stand-Alone Applications.
- Multiple Switching Frequency Options (F_{SW}):
 - 300 kHz
 - 600 kHz
- Integrated Synchronous MOSFET Drivers
- Multiple Dead-Time Options
- · Internal Blocking Device for Bootstrap Circuit
- Integrated Current Sense Capability for Short Circuit Protection
- Internal Overtemperature Protection
- Under Voltage Lockout (UVLO)
- Integrated Linear Voltage Regulator
- 10-LD 3 X 3 mm DFN Package

Applications:

- · Point of Loads
- Set-Top Boxes
- DSL Cable Modems
- FPGA's/DSP's Power Supply
- PC's Graphic/Audio Cards

General Description

The MCP19035 is an application-optimized, highspeed synchronous buck controller that operates from input voltage sources up to 30V. This controller implements a voltage-mode control architecture with a fixed switching frequency of 300 kHz or 600 kHz. The high-switching frequency facilitates the use of smaller passive components, including the inductor and input/output capacitors, allowing a compact, highperformance power supply solution. The MCP19035 implements an adaptive anti-cross conduction scheme to prevent shoot-through in the external power MOSFETs. Furthermore, the MCP19035 offers multiple dead-time options, enabling an additional degree of optimization, allowing a higher efficiency power supply design.

The MCP19035 controller is intended to be used for applications providing up to 20A of output currents across a wide input voltage range, up to 30V.

The SHDN input is used to turn the device on and off. While turned off, the current consumption is minimized.

The MCP19035 offers a Power Good feature (PWRGD), enabling fault detection and simplifying sequencing.

Package Types



Typical Application



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

V _{IN} - V _{GND}	0.3V to +32V
V _{BOOT}	0.3V to +37V
VHDRV, HDRV Pin +V _{PHASE} -0.3V	to V _{BOOT} +0.3V
VLDRV, LDRV Pin+ (V _{GND} -0.3V) to (V _{CC} +0.3V)
Max. Voltage on Any Pin+ (V_{GND}-0.3V) to (V _{CC} +0.3V)
Storage Temperature	65°C to +150°C
Maximum Junction Temperature	+150°C
ESD protection on all pins (HBM)	2 kV
ESD protection on all pins (MM)	200V

† Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

Electrical Specifications: Unless otherwise noted, $V_{IN} = 12V$, $F_{SW} = 300$ kHz, $C_{IN} = 1.0 \mu$ F, $T_A = +25^{\circ}$ C (for typical values), $T_A = -40^{\circ}$ C to $+125^{\circ}$ C (for minimum and maximum).

Parameters	Symbol	Min	Тур	Max	Units	Conditions
Inputs						
Input Voltage Range	V _{IN}	4.5		30	V	
UVLO (V _{IN} Rising)	UVLO _{ON}	4	4.2	4.4	V	
UVLO (V _{IN} Falling)	UVLO _{OFF}	3.4	3.6	3.8	V	
UVLO Hysteresis	UVLO _{HYST}		600	_	mV	
Input Quiescent Current	I(V _{IN})	—	6	8	mA	
Shutdown Current	I _{IN_SHDN}	—	25	50	μA	SHDN = GND. Internal Voltage Regulator is also disabled
Linear Regulator						
Output Voltage	V _{CC}	4.875	5	5.125	V	$6V \le V_{IN} < 30V$
Output Current	I _{VCC-OUT}	50			mA	$6.5V \leq V_{IN}$ < 30V, Note 2
Short-Circuit Output Current	Ivcc-out_sc	—	—	100	mA	V_{IN} = 6V, R_{LOAD} < 0.1 Ω
Load Regulation			0.1	_	%	Note 1
Line Regulation		_	0.05	—	%	Note 1
Dropout Voltage		—	0.75	1.3	V	I _{VCC_OUT} = 50 mA
Power Supply Rejection Ratio	PSRR		70	_	dB	$ \begin{array}{l} f \leq 1000 \text{ Hz}, \\ I_{VCC_OUT} = 50 \text{ mA} \\ C_{IN} = 0 \ \mu\text{F}, \\ C_{VCC-OUT} = 4.7 \ \mu\text{F}, \ \textbf{Note 1} \end{array} $
Internal Oscillator						
Switching Frequency	F _{SW}	255	300	345	kHz	2 options, see Section 4.4,
		510	600	690	kHz	Internal Oscillator
Ramp Signal Amplitude	V _{RAMP}	0.9	1	1.1	V _{PP}	Note 1
Reference Voltage						
Reference Voltage Generator	V _{REF}	585	600	615	mV	

Note 1: Ensured by design. Not production tested.

2: Limited by the maximum power dissipation of the case.

3: Possibility to be adjusted for high volumes.

DC ELECTRICAL CHARACTERISTICS (CONTINUED)

Electrical Specifications: Unless otherwise noted, V_{IN} = 12V, F_{SW} = 300 kHz, C_{IN} = 1.0 µF, T_A = +25°C (for typical values), T_A = -40°C to +125°C (for minimum and maximum).

Parameters	Symbol	Min	Тур	Max	Units	Conditions
Error Amplifier				1		
Gain Bandwidth Product	GBP	6.5	10		MHz	Note 1
Open Loop Gain	A _{OL}	70	80	—	dB	Note 1
Input Offset Voltage	V _{OS}	-5	0.1	5	mV	Note 1
Input Bias Current (FB Pin)	I _{BIAS}	_	—	5	nA	Note 1
Error Amplifier Sink Current	I _{SINK}	_	5	—	mA	Note 1
Error Amplifier Source Current	ISOURCE	_	5	—	mA	Note 1
PWM Section						
Maximum Duty Cycle	DC _{MAX}	85	_	_	%	Note 1
Minimum ON time	t _{ON(MIN)}	50	_	100	ns	$6V \le V_{IN}$ < 30V, Note 1
Soft Start						
Soft Start Time	t _{SS}	_	8	_	ms	
Shutdown						·
Logic Low-to-High Threshold	SHDN _{HI}	0.85	_	—	V	$4.5V \leq V_{IN}$ < 30V, V_{CC} goes from 0V to 5V
Logic High-to-Low Threshold	SHDN _{LO}	_	—	0.4	V	$4.5V \leq V_{IN}$ < 30V, V_{CC} goes from 5V to 0V
Power Good						
Power Good Threshold High	PG _{TH-H}	_	93	96	% of V _{REF}	
Power Good Threshold Low	PG _{TH-LOW}	88	90	—	% of V _{REF}	
Power Good Threshold Hysteresis	PG _{TH-HYS}	—	3	—	% of V _{REF}	
Power Good Delay	t _{PG-DELAY}	_	150	—	us	V_{FB} = (PG _{TH-HI} + 100 mV) to (PG _{TH-LOW} - 100 mV)
Power Good Active Time-Out Period	t _{PG-TIME-OUT}	_	120	—	ms	V _{FB} = (PG _{TH-HI} – 100 mV) to (PG _{TH-HI} + 100 mV)
MOSFET Drivers						
High-Side Driver Pull-up Resistance	R _{HI-SOURCE}	—	2	3.5	Ω	V _{BOOT} – V _{PHASE} = 4.5V, I _{HDRV} = 100 mA, Note 1
High-Side Driver Pull- Down Resistance	R _{HI-SINK}		2	3.5	Ω	V _{BOOT} – V _{PHASE} = 4.5V, I _{HDRV} = 100 mA, Note 1
Low-Side Driver Pull-Up Resistance	R _{LO-SOURCE}	_	2	3.5	Ω	V _{CC} = 5V, Note 1
Low-Side Driver Pull- Down Resistance	R _{LO-SINK}	_	1	2.5	Ω	V _{CC} = 5V, Note 1
HDRV Rise Time	t _{RH}		15	35	ns	C _{LOAD} = 1.0 nF, Note 1
HDRV Fall Time	t _{FH}		15	35	ns	C _{LOAD} = 1.0 nF, Note 1
LDRV Rise Time	t _{RL}	_	10	25	ns	C _{LOAD} = 1.0 nF, Note 1

Note 1: Ensured by design. Not production tested.

2: Limited by the maximum power dissipation of the case.

3: Possibility to be adjusted for high volumes.

DC ELECTRICAL CHARACTERISTICS (CONTINUED)

Electrical Specifications: Unless otherwise noted, $V_{IN} = 12V$, $F_{SW} = 300$ kHz, $C_{IN} = 1.0 \ \mu\text{F}$, $T_A = +25^{\circ}\text{C}$ (for typical values), $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ (for minimum and maximum).

values), $T_{A} = -40$ C to $+12$	values), $r_A = -400000000000000000000000000000000000$							
Parameters	Symbol	Min	Тур	Max	Units	Conditions		
LDRV Fall Time	t _{FL}	-	10	25	ns	C _{LOAD} = 1.0 nF, Note 1		
Dead Time	t _{DT}	20	—		ns	Two Dead-Time options, see		
		—	12	—		Section 5.2.2, Dead Time Selection, Note 1		
Short Circuit Protection								
High-Side Over Current Threshold Voltage	OC _{TH-HI}	430	480	530	mV	Note 1, V _{CBOOT} = 5V		
Low-Side Over Current Threshold Voltage	OC _{TH-LO}	130	180	230	mV	Note 1, Note 3		
Minimum Pulse Width During Short Circuit	t _{SS-MIN}		800		ns	Note 1		
Off-Time Between Restart Attempts (Hick- Up Time)	t _{SS-HT}	30	60	_	ms	Note 1		
Thermal Shutdown								
Thermal Shutdown	TSHD	_	150	—	°C	Note 1		
Thermal Shutdown Hysteresis	TSHD_HYS	_	15	_	S	Note 1		

Note 1: Ensured by design. Not production tested.

2: Limited by the maximum power dissipation of the case.

3: Possibility to be adjusted for high volumes.

TEMPERATURE SPECIFICATIONS

Electrical Characteristics: Unless otherwise indicated, V _{IN} = 6.0V to 30V, F _{SW} = 300 kHz							
Parameters	Sym	Min	Тур	Max	Units	Conditions	
Temperature Ranges							
Specified Temperature Range	T _A	-40	—	+125	°C		
Maximum Junction Temperature	$T_{J\text{-}MAX}$	-	—	+150	°C		
Operating Temperature Range	T _A	-40	—	+125	°C		
Storage Temperature Range	T _A	-65	—	+150	°C		
Thermal Package Resistances							
Thermal Resistance, 10L-3x3 DFN	θ_{JA}		53.3	_	°C/W	Typical 4-Layer board with interconnecting vias	

NOTES:

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, T_A = +25°C, V_{IN} = 12V, V_{OUT} = 1.8V, f_{SW} = 300 kHz, C_{VCC} = 4.7 uF.



Input Voltage.





Temperature.



Frequency Variation vs. Temperature.



Input Voltage.

+V_{CC-OUT} Regulation vs.



FIGURE 2-5: Load Current.

+V_{CC-OUT} Regulation vs.





Note: Unless otherwise indicated, T_A = +25°C, V_{IN} = 12V, V_{OUT} = 1.8V, f_{SW} = 300 kHz, C_{VCC} = 4.7 uF.



Frequency.



FIGURE 2-8: Relative Reference Voltage Variation vs. Temperature.



Temperature.



Temperature.



FIGURE 2-11: High-Side Overcurrent Threshold vs. Temperature.



FIGURE 2-12: Low-Side Overcurrent Threshold vs. Temperature.

Note: Unless otherwise indicated, T_A = +25°C, V_{IN} = 12V, V_{OUT} = 1.8V, f_{SW} = 300 kHz, C_{VCC} = 4.7 uF.



FIGURE 2-13: HDRV P-Ch R_{DSon} Relative Variation vs. Temperature.



FIGURE 2-14: HDRV N-Ch R_{DSon} Relative Variation vs. Temperature.



FIGURE 2-15: LDRV P-Ch R_{DSon} Relative Variation vs. Temperature.



FIGURE 2-16: LDRV N-Ch R_{DSon} Relative Variation vs. Temperature



FIGURE 2-17: PG Active Time Out Period vs. Temperature.



FIGURE 2-18: PG Thresholds Voltage vs. Temperature.

NOTES:

3.0 PIN DESCRIPTION

Description of the pins are listed in Table 3-1.

TABLE 3-1: PIN DESCRIPTION TABLE

MCP19035 3 x 3 DFN	Symbol	Description
1	SHDN	Device shutdown input pin
2	FB	Feedback voltage input pin
3	COMP	Internal error amplifier output pin
4	V _{IN}	Input voltage pin
5	PWRGD	Power good pin
6	+V _{CC}	+5.0V output voltage pin
7	LDRV	Lower gate drive output pin
8	BOOT	Floating bootstrap supply pin
9	PHASE	Switching node pin
10	HDRV	Upper gate drive output pin
11	EP	Exposed Thermal Pad, must be connected to GND

3.1 Shutdown Input Pin (SHDN)

This pin enables or disables the MCP19035 device. When logic "High" is applied to this pin, the device is enabled. A logic "Low" will disable the device. When the device is disabled, both the LDRV and HDRV pins are held low. The internal LDO regulator is also disabled when the SHDN pin is pulled low. Do not let this pin float. If not used, connect to $V_{\rm IN}$ using a 100 k Ω resistor.

3.2 Feedback Voltage Input Pin (FB)

This is the internal error amplifier's negative input, and is used to sense the output voltage. The positive input to the amplifier is connected to the internal reference voltage.

3.3 Internal Error Amplifier Pin (COMP)

This is the output of the internal error amplifier. The compensation network is connected between this pin and the FB pin.

3.4 Input Voltage Pin (V_{IN})

This pin is the input power for the controller. A bypass capacitor must be connected between this pin and the GND pin. The input of an internal voltage regulator (LDO) is connected to this pin to generate the +5V V_{CC} used for internal circuitry bias.

3.5 Power Good Pin (PWRGD)

The power good pin is an open drain output. This pin is pulled low when the output is 90% less than the typical value. Connect this pin to $+V_{CC}$ pin through a pull-up resistor. The recommended value for the pull-up resistor is 100 k Ω .

3.6 LDO Output Voltage Pin (+V_{CC})

This pin is the output of the internal voltage regulator (LDO). The internal circuitry of the controller is powered from this pin (+5.0V). External low noise loads can be powered from this pin, but the sum of the external load current and the internal circuitry current should not exceed 50 mA. A 4.7 μ F ceramic capacitor must be connected between this pin and GND.

3.7 Lower Gate Pin (LDRV)

This pin is the drive output for the low-side N-Channel MOSFET (synchronous rectifier). The LDRV drive is capable of sourcing 1A and sinking 1.5A.

3.8 Bootstrap Supply Pin (BOOT)

The BOOT pin is the floating bootstrap power supply pin for the high-side MOSFET gate driver. A capacitor connected between this pin and the PHASE pin provides the necessary charge to turn on the external high-side MOSFET.

3.9 Switching Node Pin (PHASE)

This pin provides a return path for the high-side gate driver. It also provides a path for the charging of the BOOT capacitor, used while turning on the high-side MOSFET. This pin also senses the switching transition to eliminate cross conduction (shoot-through).

3.10 Upper Gate Drive Pin (HDRV)

This pin is the high-side N-channel MOSFET (control transistor) gate drive output. The HDRV drive is capable of sourcing and sinking 1A.

3.11 Exposed Thermal Pad (EP)

Analog ground and power ground are both connected to this pin.

4.0 DETAILED DESCRIPTION

4.1 Device Overview

The MCP19035 family of devices are highperformance controllers providing all the necessary functions to construct a high-performance DC/DC converter, while keeping costs and design effort to a minimum:

- Support for pre-biased outputs eliminates concerns about damaging sensitive loads during startup.
- Strong gate drivers for the high-side and rectifier N-Channel MOSFETs decrease switching losses, yielding increases in efficiency.
- Adaptive gate drive timing prevents shoot-through and minimizes body diode conduction in the synchronous rectifier MOSFET, which also increases the efficiency.

- Dead-Time optimization options of the MCP19035 assist in improving the power conversion efficiency, when used with high-speed, low Figure of Merit MOSFETs.
- Overcurrent protection circuits in both high and low-side switches, and a short circuit hiccuprecovery mode increase design flexibility and minimize power dissipation in the event of prolonged output faults.
- The dedicated SHDN pin allows the converter to be placed in a low quiescent current state.
- Internal fixed converter switching frequency and soft-start reduce the external component count, simplifying design and layout, as well as reducing footprint and size.
- The 3 mm × 3 mm DFN package size also minimizes the overall converter footprint.



FIGURE 4-1:



4.2 PWM Circuitry

The MCP19035 controller implements a fixed frequency, voltage-mode control scheme. The internal PWM generator is comprised of an oscillator, error amplifier, high-speed comparator and a latch. The error amplifier generates the control voltage by amplifying the difference between voltage reference (600 mV, internally generated) and the voltage of the FB pin (feedback voltage). This control voltage is compared by the high-speed comparator to an artificially generated ramp signal; the result is a PWM signal. An SR latch (Set-Reset flip-flop) is used to prevent the PWM circuitry from turning on the external switch until the beginning of the next clock cycle.

An external Compensation Network (Type-II or Type-III) must be used to stabilize the control system.

4.3 Internal Reference Voltage V_{REF}

An integrated, precision voltage reference is provided by the MCP19035. An external resistor divider is used to program the converter's output voltage. The nominal value of this internal reference voltage is 600 mV.

4.4 Internal Oscillator

The MCP19035 device provides two switching frequency options: 300 kHz and 600 kHz.

4.5 Under Voltage Lockout Circuit (UVLO)

An integrated Under Voltage Lockout Circuit (UVLO) prevents the converter from starting until the input voltage is high enough for normal operation. The converter will typically start at 4.2V and operate down to 3.6V. Hysteresis is added to prevent starting and stopping during startup, as a result of loading the input voltage source.

4.6 Shutdown Input

The Shutdown input pin (SHDN) is used to enable and disable the controller. When the SHDN pin is pulled low, the MCP19035 is placed in Shutdown mode. During Shutdown, most of the internal circuits (including the LDO) are disabled, to minimize current consumption.

A 100 k Ω pull-up resistor is recommended between the SHDN pin and V_{IN} pin. Note that the SHDN input is a high-impedance pin. Noise generated by the circuits located near this pin may inadvertently shut down the controller. To improve the noise immunity of this input pin, we recommend placing a small capacitor between GND and SHDN, or decrease the value of the pull-up resistor. The Shutdown input pin should not be left floating.

4.7 Power Good Output (PWRGD)

This open drain output provides an indication that the output voltage is 92% (typical) of its regulated value. This output is also low for other existing conditions that signal the possibility that the output of the power supply is out of regulation. The conditions are:

- Feedback pin (FB) voltage differs more than ±8% from its nominal value (600 mV)
- · Soft-start period is active
- · Undervoltage condition detected
- Overcurrent condition detected, on either the High Side or Low Side
- Die temperature is above the thermal shutdown threshold (+150°C)

The active high power good signal has a fixed time delay of approximately 120 ms ($t_{PG-TIMEOUT}$). There is typically a 150 µs delay ($t_{PG-DELAY}$) on the power good signal high-to-low transition.



4.8 Internal Voltage Regulator (LDO)

The MCP19035 controller offers an internal 5V Low Dropout Voltage Regulator. This regulator provides the bias voltage for all internal circuits. A ceramic capacitor (4.7 μ F minimum) must be connected between the output of this LDO (V_{CC} pin) and ground (GND pin) for stable operation.

An external low noise load may be powered from this regulator, but the total current consumed from the LDO output (internal circuitry of MCP19035 + external load) should not exceed 50 mA. The internal circuitry of the MCP19035 consume approximately 5 mA. The total amount of current available to power the external load can be estimated from Equation 4-1:

EQUATION 4-1:

This LDO dissipates power within the MCP19035. To avoid tripping the Overtemperature Protection Circuit, the designer must ensure that the maximum die temperature is below +125°C under worst case conditions (i.e. high input voltage). For further information regarding the maximum dissipated power for LDOs, see Microchip's AN761 and AN792 application notes.

The LDO is protected against overload and short-circuit conditions. Consistent performance of the internal MOS drivers is ensured by monitoring the LDO output voltage; if the voltage is lower than 3.3V typical, the chip will enter in Shut-Down mode to prevent damage to the external MOSFETs.

4.9 Internal MOSFET Drivers

Internal MOSFET drivers are capable of driving external, "Logic Level" (+5V) MOSFETs.

The Low-Side Driver (LDRV) is referenced to the GND pin and is capable of sourcing 1A and sinking 1.5A.

The High-Side Driver (HDRV) is floating and capable of sourcing and sinking 1A. This driver is powered from an external bootstrap capacitor.

The drivers have non-overlapping timing that is governed by an adaptive delay circuit to minimize body diode conduction in the synchronous rectifier.

For the optimized Dead Time version of the MCP19035, the adaptive delay circuit is disabled and the Dead Time has a fixed value.

4.10 Overcurrent Protection

Overcurrent protection is accomplished by monitoring the voltage across the external MOSFETs when they are ON (conducting).

For the high-side overcurrent protection, when the sensed voltage drop across the high-side MOSFET is greater than the high-side overcurrent threshold voltage, the high-side MOSFET is immediately turned off and the high-side overcurrent counter is incremented by one. On the next cycle, if the high-side overcurrent threshold voltage is not exceeded, the high-side overcurrent counter is decreased by one count. If the high-side overcurrent counter reaches a count of 7, a fault condition exists and the MCP19035 turns off both external MOSFETs.

After a 60 ms delay, the MCP19035 will attempt to restart. If during the next cycle, a high-side overcurrent threshold voltage is measured across the high-side MOSFET, a fault is again declared and both external MOSFETs are turned off for another 60 ms. However, if after the attempted restart a high-side overcurrent threshold voltage is not measured across the high-side MOSFET, the high-side overcurrent counter is decreased by one and the MCP19035 continues to operate until the high-side overcurrent counter reaches a count of 7.

The low-side overcurrent protection behaves much the same way as the high-side overcurrent protection. The difference is that the low-side MOSFET is not immediately turned off when a low-side overcurrent threshold voltage is measured. It remains on until the next cycle begins.

For the low-side overcurrent protection, when the sensed voltage drop across the low-side MOSFET is greater than the low-side overcurrent threshold voltage specified, a low-side overcurrent counter is incremented by one count. On the next cycle, if the lowside over current threshold voltage is not exceeded, the low-side overcurrent counter is decreased by one. If the low-side overcurrent counter reaches a count of 7, a fault condition exists and the MCP19035 turns off both external MOSFETs. After a 60 ms delay, the MCP19035 device will attempt to restart. If during the next cycle, a low-side overcurrent threshold voltage is measured across the low-side MOSFET, a fault is again declared and both external MOSFETs are turned off for another 60 ms. However, if after the attempted restart a low-side overcurrent threshold voltage is not measured across the low-side MOSFET, the low-side overcurrent counter is decreased by one and the MCP19035 continues to operate until the low-side overcurrent counter reaches a count of 7.

The voltage threshold for high-side overcurrent protection circuit is fixed, 480 mV typical. The high-side voltage threshold will also depend on the value of the voltage across the bootstrap circuit capacitor, and will decrease when this voltage decreases. This will ensure that the high-side protection will avoid a failure of the MOSFET when the bootstrap voltage is low and the switching losses are high. This threshold will provide a cycle-by-cycle protection in case of short circuit, but it should not be used to provide a precise current limit for the converter. An estimation of the current that flows in the high-side MOSFET during short circuit can be found using Equation 4-2. Note that, due to the leading edge blanking time, this current also depends on the inductor's ripple current. To avoid false triggering of the high-side overcurrent protection circuit during transients, it is highly recommended to choose a MOSFET that will provide a threshold at least four times higher than the maximum output current of the converter.

EQUATION 4-2: PEAK CURRENT FOR HIGH-SIDE MOSFET

 $I_{HS \ MOS} = \frac{V_{OC \ HS}}{R_{DSON}}$ Where: $I_{HS \ MOS} = Current \ that \ passes \ through \ the \ High-Side \ MOSFET$ $V_{OC \ HS} = \ Threshold \ Voltage \ for \ High-Side \ Overcurrent \ Protection \ Circuit \ (480 \ mV)$ $R_{DSON} = \ ON \ Resistance \ of \ the \ High-Side \ MOSFET$

The voltage threshold for the low-side overcurrent protection circuit is fixed, 180 mV typical. Different values for this threshold (from 100 mV to 300 mV) are available on request. An estimation of the current that flows on the low-side MOSFET during short circuit is realized using Equation 4-3. Note that, due to the leading edge blanking time, this current also depends on the inductor's ripple current. To avoid false triggering of the low-side over current protection circuit during transients, it is highly recommended to choose a MOSFET that will provide a threshold at least two times higher than the maximum output current of the converter.

EQUATION 4-3:

1

$$I_{LS MOS} = \frac{V_{OC LS}}{R_{DSON}}$$

Where:

 I_{LS MOS} = Current that passes through the Low-Side MOSFET
V_{OC LS} = Threshold Voltage for Low-Side Overcurrent Protection Circuit (180 mV)
R_{DSON} = ON Resistance of the Low-Side MOSFET

To avoid a false trigger of the overcurrent circuit, a leading edge blanking circuit is present on both the high and low-side measurements. Due to this blanking time, the accuracy of the overcurrent circuit may be impacted if the converter operates at higher duty cycles (more than 85%), or if the inductor's current ripple is very high (i.e. the inductor is saturated by the excessive current).

4.11 Soft Start

To control the output voltage during start-up, the MCP19035 uses a soft-start circuit that allows the output voltage of the system to monotonically increase. The soft start circuitry allows the output voltage to rise up to the desired regulation limit, typically within 8 ms. The soft start circuit is enabled each time the MCP19035 starts. This includes initial start-up, start-up from toggling the SHDN pin, start-up after thermal shutdown, or start-up after an overcurrent condition.



FIGURE 4-3: Soft Start-up Diagram.

4.12 Pre-Bias Load Start-up

A special start-up sequence will prevent any current to be sourced from the output in case of a pre-biased load. This is accomplished by monitoring the FB pin and internal reference voltages. If the positive input to the Error Amplifier (internal reference voltage) is greater than the feedback voltage (voltage present at FB pin), the controller will drive the low-side MOSFET (synchronous rectifier) with a reduced duty cycle. This sequence ensures a smooth output voltage transition without sinking any current from the pre-biased external load.

Note:	Do not use a low impedance source to back-drive the output voltage during the pre-bias state. There is no protection mechanism for positive current flow in the
	synchronous rectifier MOSFET. The converter can reverse the energy flow (becoming a Boost converter) if the input
	voltage is accidentally disconnected.

NOTES:

5.0 APPLICATION INFORMATION

5.1 Typical Applications

The MCP19035 synchronous buck controller operates over an input voltage range up to a maximum of 30V. The output current capability depends only on the external MOSFET's selection and can also be very high, typically up to 20A.

Typical applications include POL modules for powering DSPs, FPGAs and ASICs, and, in general, any stepdown voltage conversion (from maximum 30V input voltage) for medium-to-high output current loads.

5.2 Design Procedure

To simplify this design process, an Excel[®]-based design tool is available to support typical applications. This tool is available on the MCP19035 product web site. Refer to AN1452 – *"Using the MCP19035 Synchronous Buck Converter Design Tool"* for further details.

5.2.1 SWITCHING FREQUENCY AND THE MAXIMUM CONVERSION RATIO

The MCP19035 controller provides two options for the switching frequency: 300 kHz and 600 kHz. In general, choosing a higher switching frequency allows the use of smaller size components (i.e. inductor and filtering capacitors), but increases the switching losses. The 300 kHz switching frequency is recommended for applications requiring output currents up to 20A. For applications requiring output currents up to 10A, the recommended switching frequency is 600 kHz.

Due to the minimum "On Time" for the high-side MOSFET driver (70 ns typical), the maximum conversion ratio must be limited to 20:1.

5.2.2 DEAD TIME SELECTION

Dead Time will affect the maximum obtainable efficiency of the converter. Selecting the Dead Time depends on the external MOSFETs' parameters. Lower Figure of Merit (FOM) transistors will permit the use of shorter Dead Times. This may increase the converter efficiency by up to 2%.

Low Figure of Merit transistors allow the user to select a low value for Dead Time (typical 12 ns) without causing a shoot-through phenomenon. For low-FOM transistors, the MCP19035 version with fixed 12 ns Dead Time is recommended.

For typical medium Figure of Merit transistors, the MCP19035 version with the adaptive Dead-Time generator is recommended.

5.2.3 INDUCTOR SELECTION

The output inductor is responsible for smoothing the square wave created by the switching action and for controlling the output current ripple (ΔI_{OUT}). There is a trade off between efficiency and load transient response time when the value of the inductor is chosen. The smaller the inductance, the quicker the converter can respond to transients in the load current. However, a smaller inductor requires a higher switching frequency to maintain the same level of output current ripple. Remember that increasing the switching frequency will also increase the switching losses in the MOSFETs.

A good compromise for the inductor current ripple is 30% of the output current. The value of the inductor is calculated in Equation 5-1:

EQUATION 5-1: INDUCTOR VALUE

$L = \left(V_{IN_{MAX}} - V_{OUT}\right) \times \frac{V_{OUT}}{V_{IN_{MAX}}} \times \frac{1}{f_{SW}} \times \frac{1}{0.3 \times I_{OUT_{MAX}}}$

The peak current in the inductor is determined in Equation 5-2:

EQUATION 5-2: INDUCTOR PEAK CURRENT

	$0.3 \times I_{OUT}$
I – I +	MAX
$L_{PEAK} = OUT_{MAX}$	2

EQUATION 5-3: INDUCTOR RMS CURRENT

	2
	$I = \frac{2}{1 + \frac{1}{Ripple}} + \frac{1}{Ripple}$
$L_{RMS} = N$	OUT 3

Additional care must be taken when selecting an inductor:

- Choose an inductor that has a saturation current larger than the calculated peak current. The tolerance of the inductor must also be considered (typically 20%).
- To minimize the conduction losses, choose an inductor with the lowest possible DC resistance. The maximum DC resistance specified in the data sheet will ensure the worst-case component specification.
- There are many magnetic materials available for inductor core: ferrite, iron powder and composite materials. The ferrite offers the lowest core losses, but the saturation characteristic is "hard" (i.e. the inductance drops rapidly after the current reaches the saturation level). The losses of iron powder or composite material cores are higher than ferrite, but the saturation characteristic is "soft", making it more suitable for voltage mode control converter, including the MCP19035.

5.2.4 INPUT CAPACITOR SELECTION

The input capacitor is responsible for providing a low impedance voltage source for the step-down converter. This capacitor must be able to sustain high ripple current, a consequence of the discontinuous input current of the buck converter. A low equivalent series resistance capacitor (ESR), preferably ceramic, is recommended. For wide temperature range applications, a multi-layer X7R dielectric is recommended, while for applications with limited temperature range, a multi-layer X5R dielectric is acceptable. A higher ESR will produce a higher voltage ripple and higher power losses. The capacitor voltage rating must be higher than the maximum operating input voltage of the converter.

The minimum capacitance is determined in Equation 5-4:

EQUATION 5-4: MINIMUM CAPACITANCE FOR INPUT CAPACITOR

$$C_{IN_MIN} = \frac{I_{OUT} \times D \times (1 - D)}{f_{SW} \times (V_{Ripple} - D \times I_{OUT} \times ESR)}$$

Where:

- C_{IN_MIN} = Minimum Capacitance of the Input Capacitor (in Farad)
 - I_{OUT} = Output Current (A)
 - D = Duty Cycle (for worst case this is 0.5)

 f_{SW} = Switching Frequency (Hz)

- V_{Ripple} = Input Voltage Ripple (usually between 0.1V and 0.5V)
 - ESR = Equivalent Series Resistance of the Capacitor (in Ohm)

The maximum ripple current in the input capacitor occurs when the duty cycle is 50%. This must be considered worst case for calculating the input capacitor.

The RMS current in the input capacitor is estimated with Equation 5-5:

EQUATION 5-5: RMS CURRENT IN THE INPUT CAPACITOR

$$I_{RMS(C_{IN})} = \left(I_{OUT} + \frac{I_{Ripple}}{12}\right) \sqrt{D} - \left(\frac{V_{OUT} \times I_{OUT}}{V_{IN}}\right)$$

The input capacitor must be rated to sustain this RMS current without considerable losses.

5.2.5 OUTPUT CAPACITOR SELECTION

The output capacitor is responsible for smoothing the output voltage. It also plays an important role in the stability of the control system. The voltage ripple across the output capacitor is the sum of ripple voltages due to the Equivalent Series Resistance (ESR) and the voltage sag due to the load current that must be supplied by the capacitor as the inductor is discharged. A low ESR capacitor, preferably ceramic, is recommended. For wide temperature range applications, a multi-layer X7R dielectric is recommended, while for applications with limited temperature range, a multi-layer X5R dielectric is acceptable.

The output voltage ripple is estimated in Equation 5-6:

r SW

EQUATION 5-6: OUTPUT VOLTAGE RIPPLE

$$V_{Ripple} = I_{Ripple} \times \left(ESR + \frac{1}{8 \times C_{OUT} \times J} \right)$$

Where:

- I_{Ripple} = Inductor Current Ripple (A)
- V_{Ripple} = Output Voltage Ripple (V)
- C_{OUT} = Output Capacitor (F)
- ESR = Equivalent Series Resistance of the Output Capacitor (Ohm)

Minimum capacitance value is calculated according to the demand of the load transient response. During a transient load current, the excessive energy stored by the inductor must be absorbed by the output capacitor until the control loop sets the proper duty cycle. Equation 5-7 calculates the minimum value for the output capacitor value:

EQUATION 5-7: OUTPUT CAPACITOR MINIMUM VALUE

$$C_{OUT} = \frac{L \times \left| I_{OH}^{2} - I_{OL}^{2} \right|}{\left| V_{f}^{2} - V_{OUT}^{2} \right|}$$

Where:

 I_{OH} = Final Value of the Output Current

- I_{OL} = Initial Value of the Output Current
- V_{OUT} = Initial Output Voltage
- V_f = Final Output Voltage

For applications that require low output voltage overshoot during a step load, the value of the output capacitor can become very large. In this case, it is recommended to mix ceramic capacitors with aluminum or polymer electrolytic capacitors to reach the recommended value.

5.2.6 MOSFETS SELECTION

Choosing the right MOSFET is a critical part of the design for a switching regulator. Their performance will directly impact the efficiency and reliability of the regulator.

The MCP19035 synchronous buck controller offers an integrated, logic-level MOSFET driver, and is capable of supplying 5V to drive the MOSFET gates. As a result, logic-level MOSFETs must be used. Suitable MOSFETs should meet the requirement of voltage and current rating.

A key parameter for evaluating the MOS transistor performance is the Figure of Merit. For a given MOSFET, this is defined as the product between the Total Gate Charge (Q_G) and $R_{DS(ON)}$ (see Equation 5-8).

EQUATION 5-8: FIGURE OF MERIT

FOM= $Q_{G(Tot)} \times R_{DS_{(ON)}}$

A lower FOM value means a higher-performance MOS transistor.

For the high-side MOSFET, power losses consist of both switching and conduction losses. Conduction losses are high when the duty cycle of the converter is high. The conduction loss of the high-side MOSFET can be estimated by multiplying the $R_{DS(ON)}$ with the RMS value of the current that passes through the transistor (see Equation 5-9).

EQUATION 5-9: RMS VALUE FOR HIGH-SIDE CURRENT

 $I_{RMS \; High-Side} = \sqrt{D \times \left(I_{OUT}^2 + \frac{I_{Ripple}}{12}\right)^2}$

Where:

- D = Duty Cycle
- I_{OUT} = Output Current (A)
- I_{Ripple} = Current Ripple in the Inductor (typically 30% of the maximum output current) (A)

The conduction losses for high-side MOS transistor are estimated in Equation 5-10:

EQUATION 5-10: CONDUCTION LOSSES FOR HIGH-SIDE MOSFET

 $P_{COND \ High-Side} = I_{RMS \ High-Side}^{2} \times R_{DS(on)HS(max)}$

The switching losses are more difficult to calculate, since they depend on many parameters. Equation 5-11 shows an estimation of these losses:

EQUATION 5-11: SWITCHING LOSSES FOR HIGH-SIDE MOSFET

$P_{SW High-Side} = \left(\frac{V_{IN} \times I_{OUT}}{2}\right) \times (t_{s(HL)} + t_{s(LH)}) \times f_{SW}$
Where:
V _{IN} = Input Voltage (V)
I _{OUT} = Output Current (A)
f _{SW} = Switching Frequency (Hz)
t _{s(HL)} = MOSFET Switching Time (High-to-Low transition) (s)
t _{s(LH)} = MOSFET Switching Time (Low-to-High transition) (s)

The $t_{\text{s(HL)}}$ and $t_{\text{s(LH)}}$ times can be estimated using the following equations:

EQUATION 5-12:

$$\begin{split} t_{s(HL)} &= \frac{Q_{G(Total)}}{I_{DRV_{Sink}}} \\ t_{s(LH)} &= \frac{Q_{G(Total)}}{I_{DRV_{Source}}} \\ \end{split}$$

 Where:

$$\begin{split} &\mathbb{Q}_{G(Total)} = \text{High-side MOSFET Total Gate} \\ &\text{Charge} \\ &\text{I}_{DRVSink} = \text{Sink Peak Current for High-Side} \\ &\text{Driver (typical 1A)} \end{split}$$

I_{DRVSource} = Source Peak Current for High-Side Driver (typical 1A)

The total power losses for the high-side MOSFET can be calculated with Equation 5-13:

EQUATION 5-13: TOTAL POWER LOSSES FOR HIGH-SIDE MOSFET

 $P_{Loss High-Side} = P_{COND High-Side} + P_{SW High-Side}$

For applications that operate with low duty cycle (lower than 30%) or high input voltage, the power losses for the high-side transistor are mainly switching losses. For these applications, it is recommended to choose a MOSFET that offers a low Total Gate Charge.

For applications that operate with duty cycles higher than 50%, the power losses for the high-side transistor are mainly conduction losses. For these applications, choose a MOSFET that has a low $R_{DS(on)}$.

The low-side MOSFET (synchronous rectifier) is "softcommutated" by the energy stored in the inductor, thus reducing the switching losses. For the low-side transistor, the power losses mainly consist of conduction losses, body diode conduction losses and body diode reverse recovery losses.

Similarly to the high-side, the RMS current that pass through the low-side MOSFET is calculated using Equation 5-14:

EQUATION 5-14: **RMS CURRENT FOR** LOW-SIDE MOSFET

$$I_{RMS\ Low-Side} = \sqrt{(1-D) \times \left(I_{OUT}^2 + \frac{I_{Ripple}^2}{I2}\right)}$$

Where:

D = Duty Cycle

- I_{OUT} = Output Current (A)
- I_{Ripple} = Current Ripple in the Inductor (typically 30% of the maximum output current) (A)

The conduction losses for low-side MOS transistor are estimated in Equation 5-15:

EQUATION 5-15: CONDUCTION LOSSES FOR LOW-SIDE TRANSISTOR

$$P_{COND \ Low-Side} = I_{RMS \ Low-Side}^{2} \times R_{DS(on)LS(max)}$$

The body diode conduction loss is calculated in Equation 5-16:

EQUATION 5-16: BODY DIODE CONDUCTION LOSSES

$$P_{LOSS BD} = I_{OUT} \times V_F \times t_{BD} \times f_{SW}$$

Where:

 V_{F} = Forward Voltage of the Body Diode (V)

 t_{BD} = Total Conduction Time for Body Diode (s)

The body diode recovery time losses will be calculated using Equation 5-17:

EQUATION 5-17: **BODY DIODE REVERSE RECOVERY LOSSES**

$$P_{RR} = \frac{Q_{RR} \times V_{IN} \times f_{SW}}{2}$$

Where:

 Q_{RR} = Reverse Recovery Charge of the Body Diode (C)

The total power loss for the low-side MOSFET can now be estimated by summing the power losses in Equation 5-18:

EQUATION 5-18: TOTAL POWER LOSS FOR LOW-SIDE MOSFET (SR)

$P_{Loss \ Low-Side} = P_{COND \ Low-Side} + P_{LOSS \ BD}$	$+ P_{RR}$
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The conduction losses are the dominant part of the total losses for the low-side transistor; choose a MOSFET with a low R_{DS(on)}.

The body diode conduction and reverse recovery losses can be greatly minimized by reducing the Dead Times necessary to prevent the shoot-through. This can be achieved by choosing transistors that have a very low Figure of Merit (FOM) MOSFET for both sides.

BOOTSTRAP CAPACITOR 5.2.7 SELECTION

The selection of the bootstrap capacitor is based upon the total gate charge of the high-side power MOSFET and the allowable droop in gate drive voltage while the high-side power MOSFET is conducting (see Equation 5-19).

EQUATION 5-19: **BOOTSTRAP CAPACITOR**

$$C_{BOOT} = \frac{Q_{G(Total)}}{\Delta V_{DROOP}}$$

Where:

Q_{G(Total)} = High-side MOSFET Total Gate Charge (C) ΔV_{DROOP} = Allowable Gate Drive Voltage Droop (V)

It is recommended that the voltage droop does not exceed 50 mV. A low ESR, ceramic capacitor, rated at least 16 V_{DC}, is recommended.

5.2.8 FEEDBACK LOOP COMPENSATION

Since the MCP19035 implements a Voltage-Mode PWM control, a Type-III compensation network is recommended. Correct placing of poles and zeros require analysis of the Bode plots for the buck converter power train.



FIGURE 5-1: Bode Plots for Buck Converter Power Train (Representation Using Asymptotes).

The power train of a buck converter that uses voltage mode control is a second order system. At the LC resonance frequency, a double pole occurs; this pole will "push" the gain down with a slope of -40db/decade. This double pole also introduces a phase lag of -180°. The compensation network must counteract the effects of this double pole in order to achieve the stability of the system.

The Equivalent Series Resistance (ESR) of the output capacitor introduces a zero that "pushes" the gain and phase up again. This zero helps the stability of the system if it occurs before the phase reaches the critical point of -180°. However, due to the performance criteria (output voltage ripple, efficiency), the application requires the use of low ESR capacitors. For capacitors that have very low ESR (ceramic capacitors), this zero occurs at high frequency, where the phase reaches the critical point.

The frequencies for pole and zero are determined using Equation 5-20:

EQUATION 5-20: POLE AND ZERO FREQUENCIES

$$f_{LC} = \frac{1}{2\pi \sqrt{L \times C_{OUT}}}$$
$$f_{ESR} = \frac{1}{2\pi \times ESR \times C_{OUT}}$$

EQUATION 5-21: PWM MODULATOR GAIN

$$A_{MOD} = 20 \times \log \frac{V_{IN}}{\Delta V_{RAMP}} = 20 \times \log V_{IN}$$

The Type-III compensation network is represented in Figure 5-2:



Network.

Type-III Compensation



FIGURE 5-3: Bode Plots for Type III Compensation Network (Representation Using Asymptotes).

Assuming $C_3 \ll C_2$ and $R_3 \ll R_1$, the pole and zero frequencies can be calculated using Equation 5-22:

EQUATION 5-22: POLE AND ZERO FREQUENCIES OF THE COMPENSATION NETWORK

$$f_{Z1} = \frac{1}{2\pi \times (R_1 + R_3) \times C_1} \cong \frac{1}{2\pi \times R_1 \times C_1}$$
$$f_{Z2} = \frac{1}{2\pi \times R_4 \times C_2}$$
$$f_{P1} = \frac{1}{2\pi \times R_4 \times \left(\frac{C_2 \times C_3}{C_2 + C_3}\right)} \cong \frac{1}{2\pi \times R_4 \times C_3}$$
$$f_{P2} = \frac{1}{2\pi \times R_3 \times C_1}$$

EQUATION 5-23: ZERO GAIN

$$A_{ZERO} = 20 \times \log \frac{R_4}{R_1}$$

EQUATION 5-24: POLE GAIN

$$A_{POLE} = 20 \times \log \frac{R_4 \times (R_1 + R_3)}{R_1 \times R_3}$$

The Type-III compensation network provides two zeros and three poles (including origin pole), pushing the cross-over frequency as high as possible, and boosts the phase margin of the system to greater than 45°. A higher bandwidth yields a faster load transient response. The faster transient response results in a smaller output voltage overshoot.

The procedure for placing the poles and zeros to achieve the optimum phase margin are presented below:

- 1. Determine the frequency of the double pole (LC pole) and ESR zero using Equation 5-20.
- 2. Choose resistor R_1 (usually between 10 k Ω and 100 k Ω). This value is a compromise between high values for additional capacitors (higher cost) and possible noise induced problems.
- 3. Resistor R₂ is calculated using Equation 5-25:

EQUATION 5-25: FEEDBACK RESISTOR DIVIDER

$$R_2 = \frac{V_{REF} \times R_I}{V_{OUT} - V_{REF}} = \frac{0.6 \times R_I}{V_{OUT} - 0.6}$$

4 Choose the crossover frequency of the compensated system. This frequency is recommended to be between 1/10th and 1/5th of the switching frequency (f_{SW}). A higher crossover frequency will improve the transient response, but will decrease the phase margin. For most of the applications, the crossover frequency is set around 1/10th of switching frequency. This is a reasonable compromise between simplifying the design of the compensation loop and achieving a fast transient response. Since the frequency of the ESR zero is much higher than LC resonant frequency, the gain of the power train can be typically approximated at the crossover frequency, using Equation 5-26:

EQUATION 5-26: POWER TRAIN GAIN AT CROSSOVER FREQUENCY

$$A_{PT_{CO}} = A_{MOD} - 40 \times log \left(\frac{f_{CO}}{f_{LC}}\right)$$

The compensated error amplifier must have a gain equal to A_{PTco} at crossover frequency (f_{CO}). Typically, this crossover frequency occurs between F_{Z2} and F_{P1} (see Figure 5-3).

5. The first zero of the compensation network must be placed at the f_{LC} frequency. The capacitor C_1 is calculated using Equation 5-27:

EQUATION 5-27: CAPACITOR C1

$$C_1 = \frac{\sqrt{L \times C_{OUT}}}{R_1}$$

6. The value of the resistor R₄ is estimated using Equation 5-28:

EQUATION 5-28: RESISTOR R4

Where:

 f_{CO} = cross-over frequency for the compensated system (usually 1/10th of f_{SW})

 $R_4 = \frac{f_{CO}}{f_{LC}} \times \frac{l}{V_{IN}} \times R_1$

7. The second zero of the compensation network must be placed at half of the f_{LC} frequency. The value of the capacitor C_2 is calculated in Equation 5-29:

EQUATION 5-29: CAPACITOR C₂

$$C_2 = 2 \times \frac{\sqrt{L \times C_{OUT}}}{R_4}$$

 The first pole of the compensation network must be placed at f_{SW.} The value of C₃ is calculated in Equation 5-30:

EQUATION 5-30: CAPACITOR C₃

$$C_3 = \frac{1}{2 \times \pi \times R_4 \times f_{SW}}$$

9. The second pole of the compensation network must be placed at half of the f_{SW} . The value for resistor R_3 is calculated in Equation 5-31:

EQUATION 5-31: RESISTOR R₃

$$R_3 = \frac{1}{\pi \times C_1 \times f_{SW}}$$

The compensation circuit can be simulated with any available simulator. The values of the components can be adjusted to meet the initial design parameters (crossover frequency and phase margin). It is also necessary to ensure that the gain of the compensation circuit does not exceed the gain of the error amplifier. Due to the interactions between poles and zeros, it is highly recommended to use the design tool provided by Microchip Technology Inc. to design and analyze the compensation network.